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Yoshida et al

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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
AA						
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FOREIGN PATENT DOCUMENTS

Examiner Initial		er	Document Number	Data	Country	Class	Subclass	Translation		
11111	uai		Number	Date	Country		Class	Subciass	Yes	No
5	LU	AM	JP 8-134435	May 1996	Japan			}		
	}	AN	JP 1-266183	Oct. 1989	Japan					
8	m	AO	JP 781932	1995	Japan					х
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		AQ	_							
		AR								
		AS								
		AT				-				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

SU	M AL	"The Rietveld Method", Oxford University Press (1993)						
,	AV	"McGraw-Hill Dictionary of Scientific and Technical Terms (5th Ed.) (1994) p. 388.						
	AV	"Particle Size Distributions from Angular Variation of Intensity of Forward-Scattered Light at Very Small Angles" J. Chem. Phys., vol 59, pp 841 - 844 (1955).						
Su	M AX	"The Determination of Pore Volume and Area Distribution in Porous Substances. I. Computations from Nitrogen Isotherms" J. Am. Chem. Soc., Vol 73, pp. 373-380 (1951).						
	AY							
	AZ							
Exan	iner	Under Considered						